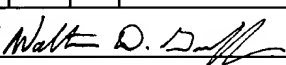


U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE										ATTY. DOCKET NO. 37,248.02		SERIAL NO. 09/779,284			
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)										APPLICANT Huff et al.		GROUP			
										FILING DATE February 8, 2001					
										U.S. PATENT DOCUMENTS					
*EXAMINER INITIAL	TRADEMARK OFFICE	DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
WG	AA	3	5	5	1	3	2	8	12/20/70	Cole et al.	208	240 208	<div style="border: 1px solid black; padding: 5px; transform: rotate(-5deg);"> RECEIVED SEP 20 2001 TC 1700 </div>		
WG	AB	3	5	6	5	7	9	3	2/23/71	Herbstman et al.	208	208			
WG	AC	3	5	9	5	7	7	8	7/27/71	Smetana et al.	208	208			
WG	AD	3	8	1	6	3	0	1	6/11/74	Sorgenti	208	208			
WG	AE	3	8	4	7	7	9	8	11/12/74	Yoo	208	208			
WG	AF	3	8	4	7	8	0	0	11/12/74	Guth et al.	208	236			
WG	AG	4	4	9	4	9	6	1	1/22/85	Venkat et al.	C10L 1	30			
WG	AH	4	7	2	3	9	6	3	2/9/88	Taylor	C10L 1	18			
WG	AI	4	8	3	0	7	3	3	5/16/89	Nagju et al.	C01B 17	00			
WG	AJ	5	1	4	7	5	2	6	9/15/92	Kukes et al.	C10G 47	18			
WG	AK	5	2	8	8	3	9	0	2/22/94	Durante	208	3			
FOREIGN PATENT DOCUMENTS															
		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
														YES	NO
WG	AL	0	4	8	2	8	4	1	29.04.92	European	C10G 27	04			
WG	AM	0	5	6	5	3	2	4	05.04.93	European	C10G 53	14			
WG	AN	0	8	5	8	8	3	5	19.08.98	European	B01J 31	02			
	AO														
	AP														
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)															
	AR														
	AS														
	AT														
EXAMINER 										DATE CONSIDERED 6-4-2002					
* EXAMINER: Initial if reference considered, without reference to citation is in accordance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.															

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U.S. PATENT DOCUMENTS															
*EXAMINER INITIAL	BA	5	7	2	0	9	0	1	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
WG									2/24/98	De Jong et al.	252	373	RECEIVED SEP 20 2001 TC 1700		
WG	BB	5	8	1	4	1	0	9	9/29/98	Cook et al.	C10L 1	18			
WG	BC	5	9	5	8	2	2	4	9/28/99	Ho et al.	208	240			
WG	BD	6	0	8	7	5	4	4	7/11/00	Wittenbrink et al.	C10L 1	08			
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		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO		
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)															
	AR														
	AS														
	AT														
EXAMINER Walter D. Huff										DATE CONSIDERED 6-4-2002					
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